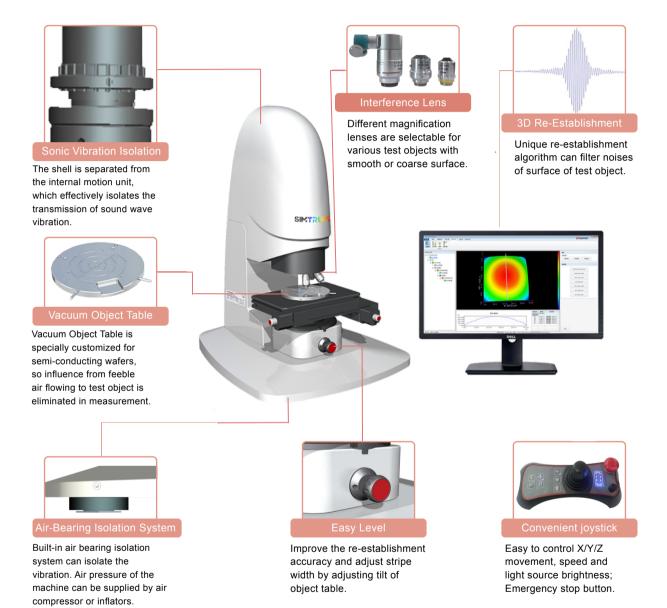
3D Optical Surface Profilometer SuperView W1

○ White Light Interferometry ● Nano 3D Surface Form and Roughness ○

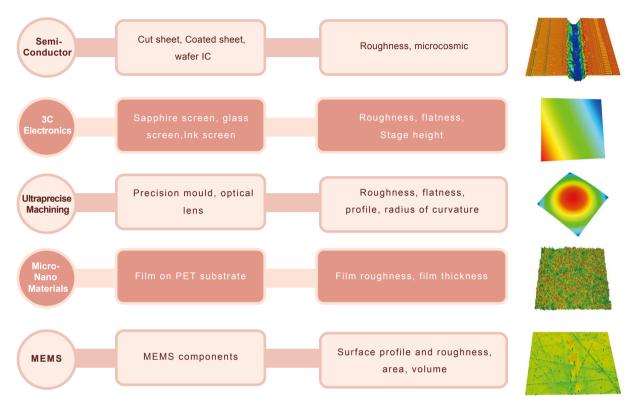




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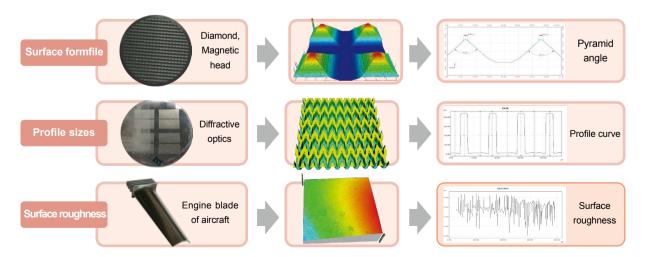
[Application]

It is used for measurement and analysis of surface roughness and profile of precision components from industries of semi-conductor, 3C Electronics, ultraprecise machining, optical machining, micro-nano materials, micro-electro-mechanical system.



[Application Case]

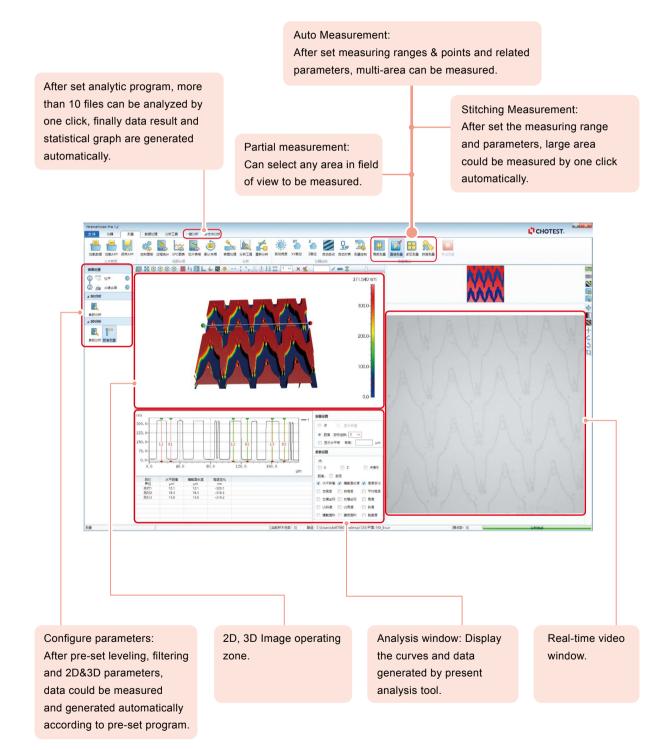
Measurement and analysis for various products, components and materials`surface form and profile characteristics, such as flatness, roughness, waviness, appearance, surface defect, abrasion, corrosion, gap, hole, stage, curvature, deformation, etc.



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[XtremeVision 3D Software]

Integration software: Measurement and analysis are operated in the same interface; With pre-set analytic parameters, the software automatically generates measurement data, and achieves rapid CNC measurement.



| Model No. | | SuperView W1 | SuperView W1-Pro | |
|------------------------------|----------------|--|------------------|--|
| Light source | | White/ Green LED | | |
| Video system | | 1024×1024 | | |
| Standard Field of View | | 0.98×0.98 mm | | |
| Max Field of View | | 6.0×6.0 mm(Optional) | | |
| Object Table | Size | (320×200)mm | (300×300)mm | |
| | Travel range | (140×100)mm | (200×200)mm | |
| | Load capacity | 10kg | | |
| | Control method | Motorized | | |
| | Tilt | ±5° Manual | | |
| Z-axis travel range | | 100mm Motorized | | |
| Z-axis stroke scanning range | | 10mm | | |
| Z-axis scanning speed | | 45µm/s | | |
| Z-axis Resolution | | 0.1nm | | |
| Lateral Resolution | | 0.1µm | | |
| Characters of Test Object | | Super-smoothing surface, coarse surface; Reflectivity 0.05%~100% | | |
| Accuracy of Stage | Accuracy | 0.3% | | |
| | Repeatability | 0.08% 1σ | | |
| Power Supply | | AC100~240V, 50/60Hz, 4A, 300W | | |
| Size | | L900*W700*H604mm | L900*W700*H700mm | |
| Weight | | <150KG | <160KG | |
| | | | | |

[Technical Parameters]

○ Standard Configuration ○-

- 1) Host machine
- 2) High speed camera
- 3) Optical zoom: 0.5X
- 4) Parfocal objective lens: 10×
- 5) Motorized X & Y object table
- 6) Manual 3 holes turret
- 6) 4.7µm stage master gauges
- 7) Joystick
- 8) XtremeVision software with automatic stitching function
- 9) Electrical control box
- 10) Computer(WIN10) and 24" monitor
- 11) Accessory suitcase
- 12) Portable inflating pump
- 13) User Manual and Product Certificate

- Optional Configuration O

- Parfocal objective lens: 2.5X, 5X, 10X, 50X, 100X
 Optical zoom: 0.75X, 1X
 Vacuum chuck: 4", 6" or 8"
- 4) Motorized 5 holes turret

Environmental requirement o—

- 1) Operating environment: No strong magnetic field
- 2) Working temperature:15°C~30°C,

fuctuation <2°C/60min

- 3) Relative humidity: 5%~95% RH, no condensation
- 4) Environmental vibration: VC-C or better
- 5) Pressure supply: 0.6Mpa oil-free, water-free,

6mm diameter of hose

3D Optical Surface Profilometer SuperView W3

-○ Large-scale microscopic 3D form and shape ○-



- Large table
- Applicable for 12" wafer
- One-key automatic measurement

[Dedicated Functions for Semiconductor Field]

- Measure profile trenches after laser grooving in the dicing process.
- Measure film step-height of wafer ranging from 1nm~1mm.
- Measure roughness of silicon cut sheet after grinding process, and can measure dozens of small areas to obtain the average value by one click.
- Support 6", 8" and 12" wafer measurement, and easy switch between 3 sizes of vacuum chucks by one click automatically.

[Technical Parameters]

| Model No. | | SuperView W3 | |
|------------------------------|----------------|--|--|
| Light source | | White/ Green LED | |
| Video system | | 1024×1024 | |
| Standard Field of View | | 0.98×0.98 mm | |
| Max Field of View | | 6.0×6.0 mm(Optional) | |
| Object Table | Size | (450×450)mm | |
| | Travel range | (300×300)mm | |
| | Load capacity | 10kg | |
| | Control method | Motorized | |
| Level adjustment | | Lens tilt, motorized | |
| Z-axis travel range | | 100mm Motorized | |
| Z-axis stroke scanning range | | 10mm | |
| Z-axis scanning speed | | 45µm/s | |
| Z-axis Resolution | | 0.1nm | |
| Lateral Resolution | | 0.1µm | |
| Characters of Test Object | | Super-smoothing surface, coarse surface; Reflectivity 0.05%~100% | |
| Accuracy of Stage | Accuracy | 0.3% | |
| | Repeatability | 0.08% 1σ | |
| Power Supply | | AC200~240V, 50/60Hz, 4A, 600W | |
| Size | | L1000*W900*H1500mm | |
| Weight | | <500KG | |
| | | | |

O Standard Configuration O

- 1) Host machine
- 2) High speed camera
- 3) Optical zoom: 0.5X
- 4) Parfocal objective lens: 10×
- 5) Motorized X & Y object table
- 6) Manual 3 holes turret
- 6) 4.7µm stage master gauges
- 7) Joystick
- XtremeVision software with automatic stitching function
- 9) Electrical control box
- 10) Computer(WIN10) and 24" monitor
- 11) Accessory suitcase
- 12) Portable inflating pump
- 13) User Manual and Product Certificate

─○ Optional Configuration ○

1) Parfocal objective lens: 2.5X, 5X, 10X, 50X,

100X

- 2) Optical zoom: 0.75X, 1X
- 3) Vacuum chuck: 4", 6", 8" or 12"
- 4) Motorized 5 holes turret

O Environmental requirement O

- 1) Operating environment: No strong magnetic field
- 2) Working temperature:15°C~30°C,

fuctuation <2°C/60min

- 3) Relative humidity: 5%~95% RH, no condensation
- 4) Environmental vibration: VC-C or better
- 5) Pressure supply: 0.6Mpa oil-free, water-free, 6mm diameter of hose

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